Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/593,060	EGUCHI ET AL.	
Examiner	Art Unit	
Oi Han	2626	

SEARCHED					
Class	Subclass	Date	Examiner		
		:			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

DATE	EXMR
6/30/2006	QH